Results for 3D Crossbar feed forward algorithm

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1 Algorithm

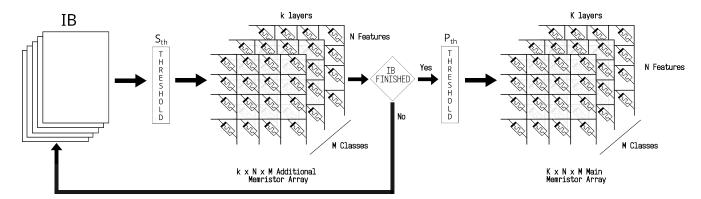


Figure 1: Flow of the algorithm.

The overall flow of the proposed learning algorithm is depicted in Fig. 1. We assume that N is the number of input attributes, and M is the number of classes in the classification problem. In the figure, NN-chip refers to the $N \times M \times K$ memristor crossbar that is used in learning, and the additional memristors (AM) denote an $N \times M \times k$ memristor array used for thresholding. Here, $K = \lceil \frac{total_number_of_samples}{k} \rceil$ and $k = \lceil \log_2(batch_size) \rceil$.

In the algorithm, inputs are applied one at a time from an input batch $\mathbf{IB} = \{\mathbf{IB}_0, \mathbf{IB}_1, \dots, \mathbf{IB}_{K-1}\}$, where each batch \mathbf{IB}_i consists of k sub-batches $\mathbf{IB}_i = \{\mathbf{SB}_{i0}, \mathbf{SB}_{i1}, \dots, \mathbf{SB}_{ik-1}\}$. Let k denote the number of inputs in \mathbf{SB}_{ij} , for all $0 \le i < k$. Each sub-batch \mathbf{SB}_{ij} consists of Minputs, one from each class. The inputs in the sub-batches are applied for training in parallel with respect to the classes. For each class i, every sub-batch \mathbf{SB}_{ij} will first update the AMs.

On the host, we have two arrays called P_{th} , S_{th} both of size M i.e. the number of classes. Additionally, two learning rates, alpha and beta are there for training P_{th} and Sth respectively.

For the MNIST dataset, each image has 28×28 pixels, where each pixel is treated as a single attribute, and hence N=784. When an input from a sub-batch is processed, it is first passed through a threshold stored in P_{th} based on its class. If the given input attribute is greater than the threshold, a voltage V_{sc} sufficient to increase the conductive state by one unit is applied to the respective memristor in AM. Since the slices of the classes in the Additional memristor Crossbar Array are not connected, we can process these updates in parallel in a single cycle, in a manner similar to MAGIC. The whole sub-batch is processed in this manner. The process is repeated until there are no sub-batches left in the Input Batch. After this stage, the AMs are loaded with useful information in the form of weights.

The weights of the NN-chip memristors in the column corresponding to the class in which input inp belongs are then updated. A threshold filter is applied at this level to achieve weight updation, which helps to classify the most and least matched information. Based on the filtered values stored in AM after thresholding, the weights are updated in the respective column of the NN-chip. All the AMs are then reset to state 0, and the process is repeated for the next input batch until all the K input batches are processed and the NN is at capacity.

After this, a projection of the NN Crossbar is taken along K layers to get an $N \times M$ matrix. The training inputs of size $N \times 1$ are multiplied with the projected matrix to get the similarity with each of the M classes. The index with the highest value is the predicted class. All the inputs are processed and the wrong predictions per-class are stored. This is used to update the thresholds in P_{th} and S_{th} by multiplying the wrong predictions with the respective learning rates.

This process is repeated over a number of epochs until the desired accuracy is achieved.

1.1 Latency

Let's assume: a dataset of size 'D' where data within a single class forms a batch and the number of classes equals the number of IBs (both denoted by 'M'). We'll also assume that training input counts are equal across classes, leading to 'K' sub-batches per IB_i and each IB_{ij} having a size of 'k'.

Algorithm 1 Feed Forward Learning Algorithm with Threshold Updates

INPUT: Number of NN layers (k), input feature dimension (n), number of classes (M), AM Crossbar bit resolution (q), total number of training samples $(total_samples)$, input masking threshold $(P_{th}$ initial), scaling threshold $(S_{th}$ initial), learning rate for scaling threshold (α) , learning rate for masking threshold (β)

OUTPUT: Trained NN Crossbar weights, updated thresholds (P_{th} final, S_{th} final)

```
1: batch\_size = 100
2: Initialize NN Crossbar: NN \leftarrow \text{Crossbar}(K, N, M)
3: Initialize AM Crossbar: AM \leftarrow \text{Crossbar}(k, N, M)
4: for epoch \in range(0, epochs) do
      for batch_index \in range(0, K) do
        mask \leftarrow get\_mask(input\_batch, P_{th})
6:
7:
         AM.update\_layer(mask)
        if batch_index % batch_size == 0 then
8:
9:
           am\_mask \leftarrow get\_mask(AM.get\_xy\_sum\_projection(2), S_{th})
10:
           NN.update\_layer(am\_mask)
11:
        end if
12:
      end for
13:
14:
      out \leftarrow NN.get\_xy\_sum\_projection(2)
      normalize(out)
15:
      wrongs \leftarrow \text{test}(out)
16:
      for i \in range(0, M) do
17:
         S_{th}[i] + = \alpha \cdot wrongs[i]
18:
19:
         P_{th}[i] += \beta \cdot wrongs[i]
20:
      end for
21: end for
22: return out (trained weights)
```

Since updating AMs takes one cycle per training input, a complete sub-batch needs 'p' cycles for AM updates. We'll also need one cycle for the NN-chip update and another to reset the AMs. Therefore, a single sub-batch's processing requires a total of $C_{IB_{ij}}=k+2$ cycles. To process a whole class, we multiply the cycles for a single sub-batch by the number of sub-batches in that class: $C_{IB}=C_{IB_{ij}}\times K$.

Calculating the cycles for training the entire dataset over a single epoch involves summing the cycles for each class: $C_D = C_{IB}$, since they are computed parallelly. The algorithm usually needs around 8 to 10 epochs for optimal accuracy, so the average training cycle count is approximately $10 \times C_D$.

2 Results

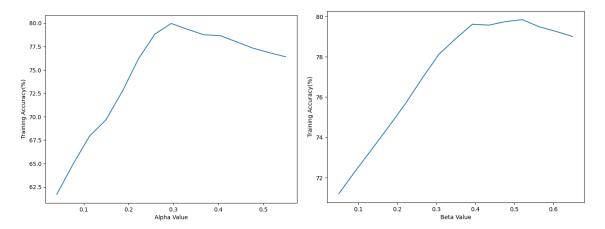


Figure 2: (a) Impact of alpha on the training, (b) Impact of beta on the training.

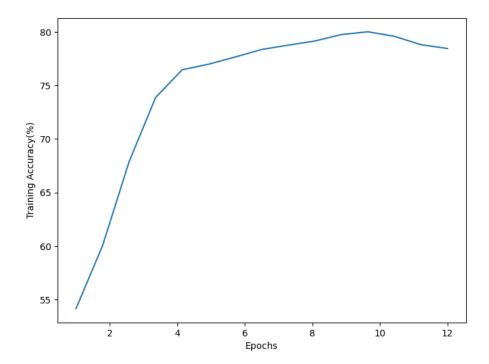


Figure 3: Progress of the training process over 12 epochs.

Table 1: Performance comparison of the proposed algorithm.

Approach	Description	Input size	Net-Size	Accuracy	# of epochs	Accuracy%
Proposed	HSBT	784 (28 × 28)	784→10	80.00%	10	_
[1]	HSBT	$784 (28 \times 28)$	$784 \rightarrow 10$	94.00%	10	-14
[2]	HSBT BP	$760 (19 \times 20)$	$760\rightarrow10$	89.90%	_	-9.9
[3]	HSBT BP	$49 (7 \times 7)$	$50 \to 10$	92.00%	_	-12
[4]	HABT BP	$784 (28 \times 28)$	$784{\rightarrow}\ 42{\rightarrow}10$	92.00%	1000	-12
[5]	HSBT BP	$784 (28 \times 28)$	$784 \rightarrow 10$	83.85%	10	-3.85
	HSBT RWC	784 (28 × 28)	AlexNet	94.79%	1000	-14.79
[6]	HSBT BP + RWC			98.81%		-18.81
[6]	HSBT Delta Rule			85.19%		-5.19
	HSBT RWC+Delta			97.95%		-17.95
[7]	HABT (OCTAN)	64 (8 × 8)	$64 \rightarrow 100 \rightarrow 10$	81.80%	52	-1.8
[8]	HABT SLMS 25 (5 × 5)		84.00%	250	-4.00	
[O]	HABT LMS	23 (3 × 3)		82.00%	230	-2.00

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